	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment s
1	BRS	L1	0	2001/016605	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:10	
2	BRS	L2	О	2001/0160605	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:11	
3	BRS	L3	24	"0160605"	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:11	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment
4	BRS	L4	1	2002/0160605	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:16	·
5	BRS	L 5	13981	kanazawa	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:16	
6	BRS	L6	0	5 and (huv-cvd or huv near cvd)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:17	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment s
7	BRS	L 7	0	5 and (huv-cvd) or (huv near cvd)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:18	
8	BRS	L8	0	5 and (uvh-cvd) or (uvv near cvd)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:18	
9	BRS	L9	430	5 and (uhv-cvd) or (uhv near cvd)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:18	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment
10	BRS	L10	90	5 and (uhv-cvd) or (uhv near cvd) near25 (gas)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:20	
11	BRS	L11	127	5 and (uhv-cvd) or (uhv near cvd) near25 (pressure)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:21	
12	BRS	L12	1	5 and (uhv-cvd) or (uhv near cvd) near25 (pressure) near25 (sic)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:21	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment s
13	BRS	L13	1	5 and (uhv-cvd) or (uhv near cvd) near25 (pressure) near25 (temp\$5)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:22	
14	BRS .	L14	4	5 and (uhv-cvd) or (uhv near cvd) near25 (pressure) near25 (carbon)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB		
15	BRS	L15	297	(uhv-cvd) or (uhv near cvd) near25 (pressure) near25 (carbon)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:08	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment
16	BRS	L16	297	(uhv-cvd) or (uhv near cvd) near25 (pressure) near25 (carbon) near35 (temp\$5)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:23	
17	BRS	L17	297	(uhv-cvd) or (uhv near cvd) near25 (pressure) near25 (carbon near5 gas) near35 (temp\$5)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:23	
18	BRS	L18	132	(wafer or substrate) near25 (uhv-cvd) or (uhv near cvd) near25 (pressure) near25 (carbon near5 gas) near35 (temp\$5)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:24	

	Туре	L#	Hits	Search Text	DBs	Time Stamp	Comment s
19	BRS	L19	15	<pre>(wafer or substrate) near25 (crystal\$3) near15 (uhv-cvd) or (uhv near cvd) near25 (pressure) near25 (carbon near5 gas) near35 (temp\$5)</pre>	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:30	
20	BRS	L20	104	(wafer or substrate) near25 (crystal\$3 or silicon or si) near15 (uhv-cvd) or (uhv near cvd) near25 (pressure) near25 (carbon near5 gas) near35 (temp\$5)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:52	
21	BRS	L21	104	(wafer or substrate) near25 (silicon or si) near15 (uhv-cvd) or (uhv near cvd) near25 (pressure) near25 (carbon near5 gas) near35 (temp\$5)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:53	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment
22 .	BRS	L22	104	(wafer or substrate) near25 (silicon or si) near15 (uhv-cvd) or (uhv near cvd) near25 (pressure) near25 (two near carbon near5 gas) near35 (temp\$5)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:54	
23	BRS	L23	104	(wafer or substrate) near25 (silicon or si) near15 (uhv-cvd) or (uhv near cvd) near25 (pressure) near25 (two near carbon near gas) near35 (temp\$5)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:55	
24	BRS	L24	104	(wafer or substrate) near25 (silicon or si) near15 (uhv-cvd) or (uhv near cvd) near25 (pressure) near25 (two near carbon) near (alloy or gas) near35 (temp\$5)	PUB; EPO;	2004/10/0 6 15:55	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment s
25	BRS	L25	104	(uhv near cvd) near25 (pressure) near25 (two near carbon) near	PUB; EPO;	2004/10/0 6 16:53	
26	BRS .	L26	0	<pre>(wafer or substrate) near25 (silicon or si) near15 ((uhv-cvd) or (uhv near cvd)) near25 (pressure) near25 ((two near carbon) near (alloy)) near35 (temp\$5)</pre>	PUB;	2004/10/0 6 15:56	
27	BRS	L27	0	(wafer or substrate) near25 (silicon or si) near15 ((uhv-cvd) or (uhv near cvd)) near25 (pressure) near25 (two near carbon) near35 (temp\$5)	EPO;	2004/10/0 6 15:57	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment
28	BRS	L28	0	(wafer or substrate) near25 (silicon or si) near15 ((uhv-cvd) or (uhv near cvd)) near25 (pressure) near25 (carbon or alloy) near35 (temp\$5)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:57	
29	BRS	L29	0	<pre>(wafer or substrate) near25 (silicon or si) near15 ((uhv-cvd) or (uhv near cvd)) near25 ((pressure) near25 (carbon or alloy)) near35 (temp\$5)</pre>	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 15:58	
30	BRS	L30	2	(wafer or substrate) near25 (silicon or si) near15 ((uhv-cvd) or (uhv near cvd)) near25 (pressure) near25 (carbon or alloy)	EPO;	2004/10/0 6 16:01	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment s
31	BRS	L31	0	(wafer or substrate) near25 (silicon or si) near15 ((uhv-cvd) or (uhv near cvd)) near25 (pressure) near25 (carbon near5 alloy)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 16:01	
32	BRS	L32	0	(wafer or substrate) near25 (silicon or si) near15 ((uhv-cvd) or (uhv near cvd)) near25 (pressure) near25 (silicon near3 alloy)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 16:01	
33	BRS	L33	0 .	(wafer or substrate) near25 (silicon or si) near15 ((uhv-cvd) or (uhv near cvd)) near25 (pressure) near25 (silicon near5 alloy)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB		

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment
34	BRS	L34	0	<pre>(wafer or substrate) near25 (silicon or si) near15 ((uhv-cvd) or (uhv near cvd)) near25 (pressure) near25 ((silicon or si) near5 (alloy))</pre>	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 16:02	
35	BRS	L35	0	<pre>(wafer or substrate) near25 (silicon or si) near15 ((uhv-cvd) or (uhv near cvd)) near25 (pressure) near25 ((silicon or si) near25 (alloy))</pre>	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 16:03	
36	BRS	L36	O	<pre>(wafer or substrate) near25 (silicon or si) near15 ((uhv-cvd) or (uhv near cvd)) near25 (pressure) near25 ((silicon or si or carbon) near25 (alloy))</pre>	PUB;	2004/10/0 6 16:03	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment
37	BRS	L37	15058	two near carbon near atom\$1	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 16:09	
38	BRS	L38	. 192	(two near carbon near atom\$1) near15 (gas)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 16:09	
39	BRS	L39	54	(two near carbon near atom\$1) near15 (gas near containing)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 16:45	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment
40	BRS	L41	0	(double or triple) near10 (two near carbon near atom\$1) near15 (gas near containing) near15 (oxygen)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 16:13	•
41	BRS .	L40	26	(two near carbon near atom\$1) near15 (gas near containing) near15 (oxygen)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 16:15	
42	BRS	L42	26	(two near carbon near atom\$1) near15 (gas near containing) near15 (oxygen near15 atoms)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 16:18	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment s
43	BRS	L43	0	(two near carbon near atom\$1) near15 (gas near containing) near15 (oxygen) near15 (ethylene or acetylene)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 16:19	
44	BRS	L44	0	(two near carbon near atom\$1) near15 (gas near containing) near15 (oxygen) near15 (ethylene or acetylene)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 16:19	
45	BRS	L45	26	(two near carbon near atom\$1) near15 (gas near containing) near15 (oxygen)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 16:42	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment
46	BRS	L46	73	(two or three) near (carbon near atom\$1) near15 (gas near containing)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 16:45	
47	BRS	L47	3459	(carbon near5 gas) near25 (ethy1\$3 or acety1\$3)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 16:56	
48	BRS	L49	4	(carbon near5 gas near5 crystal) near25 (ethyl\$3 or acetyl\$3)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:00	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment
49	BRS	L48	5	(carbon near5 gas near5 alloy) near25 (ethyl\$3 or acetyl\$3)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 16:56	
50	BRS	L50	9	(carbon near5 gas near5 crystal) near25 (electrical\$2)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 16:57	
51	BRS	L51	419	(carbon near5 gas near5 oxygen) near25 (ethy1\$3 or acety1\$3)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:01	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment s
52	BRS	L52	0	(carbon near5 gas near5 oxygen) near25 (ethy1\$3 or acety1\$3) near15 (less near than)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:01	,
53	BRS	L53	2	(carbon near5 gas near5 oxygen) near25 (ethy1\$3 or acety1\$3) near15 (less or than)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:04	
54	BRS	L54	0	(carbon near5 gas near5 oxygen) near25 (diborane or phosphine) near15 (less or than)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:04	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment s
55	BRS	L55	4	(gas near5 oxygen) near25 (diborane or phosphine) near15 (less or than)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:04	
56	BRS	L57	0	56 and (silicon near carbon)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:05	
57	BRS	L58	103	56 and (silicon or carbon)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:05	,

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment s
58	BRS	L56	136	(gas) near25 (diborane or phosphine) near15 (less or than)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:06	
59	BRS	L59	0	(gas) near25 (diborane near phosphine near arsine) near15 (less or than)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:07	
60	BRS	L60	3	(gas) near25 (diborane near5 phosphine near5 arsine) near15 (less or than)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:07	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment
61	BRS	L61	11	(gas) near25 (diborane) near5 (phosphine or arsine) near15 (less or than)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:08	
62	BRS	L62	297	(uhv-cvd) or (uhv near cvd) near25 (pressure) near25 (wafers)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:09	
63	BRS	L63	297	(uhv-cvd) or (uhv near cvd) near25 (pressure) near25 (plurality ear3 wafers)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:09	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment
64	BRS	L64	297	(uhv-cvd) or (uhv near cvd) near25 (pressure) near25 (plurality near3 wafers)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:09	
65	BRS	L65	297	(uhv-cvd) or (uhv near cvd) near25 (pressure) near25 (plurality near wafers)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:09	
66	BRS	L66	1	((uhv-cvd) or (uhv near cvd)) near25 (pressure) near25 (plurality near wafers)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:10	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment
67	BRS	L67	400	silicon near carbon near alloy	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:10	
68	BRS	L68	0	(silicon near carbon near alloy) near15 (poly and crystal\$3)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:10	
69	BRS	L69	16	(silicon near carbon near alloy) near15 (poly or crystal\$3)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:11	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment s
70	BRS	L70	76	crystal\$3)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:11	·
71	BRS	L71	1	(carbon near alloy) near15 (poly or crystal\$3) near15 (oxygen)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:11	
72	BRS	L72	1933	(carbon or alloy) near15 (poly or crystal\$3) near15 (oxygen)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:11	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment s
73	BRS	L73	1933	((carbon or alloy)) near15 (poly or crystal\$3) near15 (oxygen)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:11	
74	BRS	L74	8	((carbon near5 alloy)) near15 (poly or crystal\$3) near15 (oxygen)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:12	
75	BRS	L75	0	(carbon near alloy) near15 (poly) near15 (oxygen)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:12	

	Туре	L#	Hits	Search Text	DBs	Time Stamp	Comment
76	BRS	L76	20	(carbon near5 alloy) near15 (poly\$4) near15 (oxygen)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17 : 13	
77	BRS	L77		(carbon near5 alloy) near15 (polycrystal\$3) near15 (oxygen)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:13	
78	BRS	L78	0	(carbon near5 alloy) near15 (poly-crystal\$3) near15 (oxygen)	USPAT; US-PG PUB; EPO; JPO; DERWE NT; IBM_T DB	2004/10/0 6 17:14	

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment s
79	BRS	L79	8	(carbon near5 alloy) near15 (crystal\$3) near15 (oxygen)		2004/10/0 6 17:14	•

	υ	1	Document ID	Title	Current OR	Pages
1		Ŧ	US 20040161911 A1	Epitaxial and polycrystalline growth of Sil-x-yGexCy and Sil-yCy alloy layers on Si by UHV-CVD	438/479	21
2			US 20040161875 A1	Epitaxial and polycrystalline growth of Sil-x-yGexCy and Sil-yCy alloy layers on Si by UHV-CVD	438/105	21
3		•	US 20040092085 A1	Semiconductor crystal film and method for preparation thereof	438/479	19
4			US 20030203599 A1	Semiconductor wafer and method for fabricating the same	438/478	12
5			US 20030146473 A1	Semiconductor device	257/346	25
6	0		US 20020189535 A1	Method for manufacturing semiconductor crystal film	117/105	13

	ט	1	Document ID	Title	Current OR	Pages
7			US 20020182423 A1	Epitaxial and polycrystalline growth of Sil-x-yGexCy and Sil-yCy alloy layers on Si by UHV-CVD	428/446	21
8			US 20020160584 A1	Semiconductor wafer and method for fabicating the same	438/478	12
9			US 6750119 B2	Epitaxial and polycrystalline growth of Sil-x-yGexCy and Sil-yCy alloy layers on Si by UHV-CVD	438/479	19
10				Method of forming a semiconductor wafer having a crystalline layer thereon containing silicon, germanium and carbon	438/509	13
11			US 6399993 B1	Semiconductor device and method for fabricating the same	257/370	30

	U	1	Document I	D	Title	Current	OR	Pages
12			US 6030894		Method for manufacturing a semiconductor device having contact plug made of Si/SiGe/Si			18

	U	1	Document ID	Title	Current	OR	Pages
13			US 5909059 A	Semiconductor device having contact plug and method for manufacturing the same	257/750		
14	×		JP 10256153 A	METHOD FOR CONVERTING AMORPHOUS SI LAYER TO SINGLE CRYSTAL AT LOW TEMPERATURE			11
15			JP 10256153 A	Crystallisation of non-crystal silicon@ layer for semiconductor LSI manufacture - involves maintaining predetermined oxygen density and hydrogen concentration in non-crystal silicon@ layer			11